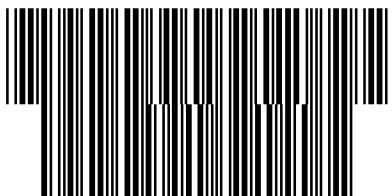


Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	1007474310016765	BRENNER ET AL.KAIZU ET AL.
	Examiner Shang, Annan Q.Shang, Annan Q.	Art Unit 24242424

SEARCHED			
Class	Subclass	Date	Examiner
725	58,78-85,131-134,139-142,106-120	09/09/10	/A.S./
709	217-231	09/09/10	/A.S./
345	169,553,556,173,716,717,722,901	09/09/10	/A.S./
348725	73432, 40-43, 48-51, 54-55, 86-92, 100-103, 114-115, 135-136	09/09/109/28/06	/A.S./JM

SEARCH NOTES			
Search Notes		Date	Examiner
EAST		10/1/2006	CML
EAST		4/30/2007	CML
Updated search		7/2/08	/A.S./
Updated search		1/26/09	/A.S./
Updated search		6/30/09	/A.S./
Updated search		12/16/09	/A.S./
Updated Search		04/06/10	/A.S./
Updated searchEAST Search included		09/09/109/28/06	/A.S./JM
Spoke with Scott Beliveau		9/28/06	JM
Updated search		6/11/08	/A.S./
Updated search		3/9/09	/A.S./
Updated search		03/23/10	/A.S./
Updated search		10/6/10	/A.S./

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
725	58,78-85,131-134,139-142,106-120	09/30/10	/A.S./
709	217-231	09/30/10	/A.S./
345	69,553,556,173,716,717,722,901	09/30/10	/A.S./
348	734	09/30/10	/A.S./

--	--